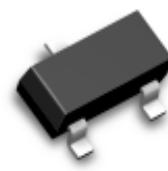


General Purpose Transistor (PNP)

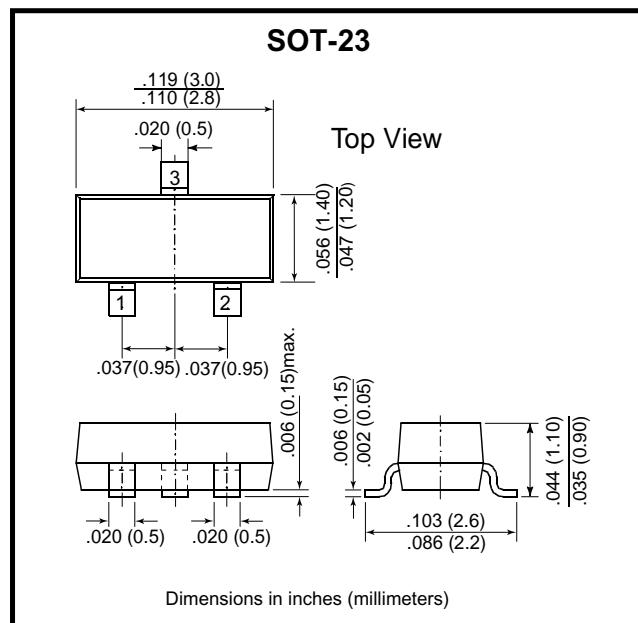
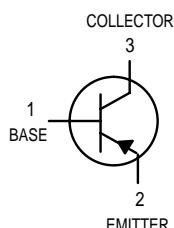
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MMBT3906 PNP Silicon Type



Features

- Epitaxial Planar Die Construction
- Complementary NPN Type Available (MMBT3904)
- Ideal for Medium Power Amplification and Switching



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	-40	Vdc
Collector-Base Voltage	V_{CBO}	-40	Vdc
Emitter-Base Voltage	V_{EBO}	-5.0	Vdc
Collector Current — Continuous	I_C	-200	mAdc

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation FR-5 Board ⁽¹⁾ $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	225	mW
		1.8	$\text{mW}/^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	556	$^\circ\text{C}/\text{W}$
Total Device Dissipation Alumina Substrate, ⁽²⁾ $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	300	mW
		2.4	$\text{mW}/^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	417	$^\circ\text{C}/\text{W}$
Junction and Storage Temperature	T_J, T_{stg}	-55 to +150	$^\circ\text{C}$

General Purpose Transistor

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ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

OFF CHARACTERISTICS	Symbol	Min	Max	Unit
Collector-Emitter Breakdown Voltage ⁽³⁾ ($I_C = -1.0 \text{ mA}, I_B = 0$)	$V_{(\text{BR})\text{CEO}}$	-40	—	Vdc
Collector-Base Breakdown Voltage ($I_C = -10 \mu\text{A}, I_E = 0$)	$V_{(\text{BR})\text{CBO}}$	-40	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = -10 \mu\text{A}, I_C = 0$)	$V_{(\text{BR})\text{EBO}}$	-5.0	—	Vdc
Base Cutoff Current ($V_{CE} = -30 \text{ Vdc}, V_{EB} = -3.0 \text{ Vdc}$)	I_{BL}	—	-50	nAdc
Collector Cutoff Current ($V_{CE} = -30 \text{ Vdc}, V_{EB} = -3.0 \text{ Vdc}$)	I_{CEX}	—	-50	nAdc

1. FR-5 = $1.0 \times 0.75 \times 0.062$ in.

REM : Thermal Clad is a trademark of the Bergquist Company.

2. Alumina = $0.4 \times 0.3 \times 0.024$ in. 99.5% alumina.

3. Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted) (Continued)

ON CHARACTERISTICS ⁽³⁾	Symbol	Min	Max	Unit
DC Current Gain ($I_C = -0.1 \text{ mA}, V_{CE} = -1.0 \text{ Vdc}$) ($I_C = -1.0 \text{ mA}, V_{CE} = -1.0 \text{ Vdc}$) ($I_C = -10 \text{ mA}, V_{CE} = -1.0 \text{ Vdc}$) ($I_C = -50 \text{ mA}, V_{CE} = -1.0 \text{ Vdc}$) ($I_C = -100 \text{ mA}, V_{CE} = -1.0 \text{ Vdc}$)	H_{FE}	60 80 100 60 30	— — 300 — —	—
Collector-Emitter Saturation Voltage ($I_C = -10 \text{ mA}, I_B = -1.0 \text{ mA}$) ($I_C = -50 \text{ mA}, I_B = -5.0 \text{ mA}$)	$V_{CE(\text{sat})}$	— —	-0.25 -0.4	Vdc
Base-Emitter Saturation Voltage ($I_C = -10 \text{ mA}, I_B = -1.0 \text{ mA}$) ($I_C = -50 \text{ mA}, I_B = -5.0 \text{ mA}$)	$V_{BE(\text{sat})}$	-0.65 —	-0.85 -0.95	Vdc

SMALL-SIGNAL CHARACTERISTICS

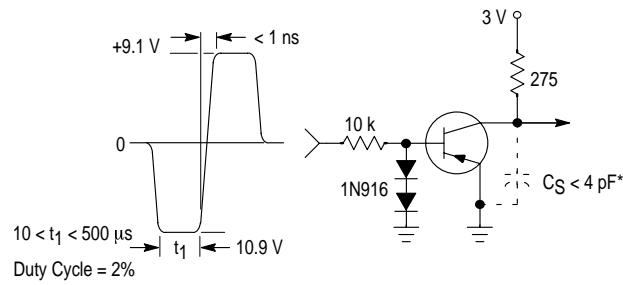
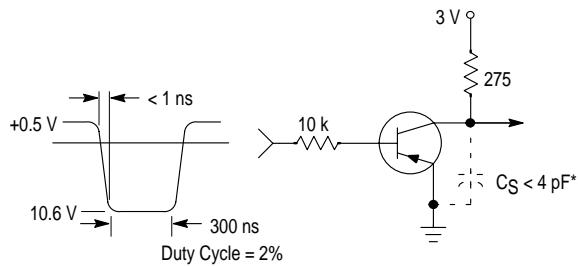
Current-Gain — Bandwidth Product ($I_C = -10 \text{ mA}, V_{CE} = -20 \text{ Vdc}, f = 100 \text{ MHz}$)	f_T	250	—	MHz
Output Capacitance ($V_{CB} = -5.0 \text{ Vdc}, I_E = 0, f = 1.0 \text{ MHz}$)	C_{obo}	—	4.5	pF
Input Capacitance ($V_{EB} = -0.5 \text{ Vdc}, I_C = 0, f = 1.0 \text{ MHz}$)	C_{ibo}	—	10	pF
Input Impedance ($I_C = -1.0 \text{ mA}, V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}$)	h_{ie}	2.0	12	k Ω
Voltage Feedback Ratio ($I_C = -1.0 \text{ mA}, V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}$)	h_{re}	0.1	10	$\times 10^{-4}$
Small-Signal Current Gain ($I_C = -1.0 \text{ mA}, V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}$)	h_{fe}	100	400	—
Output Admittance ($I_C = -1.0 \text{ mA}, V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}$)	h_{oe}	3.0	60	μmhos
Noise Figure ($I_C = -100 \mu\text{A}, V_{CE} = -5.0 \text{ Vdc}, R_S = 1.0 \text{ k}\Omega, f = 1.0 \text{ kHz}$)	NF	—	4.0	dB

SWITCHING CHARACTERISTICS

Delay Time	$(V_{CC} = -3.0 \text{ Vdc}, V_{BE} = 0.5 \text{ Vdc}, I_C = -10 \text{ mA}, I_{B1} = -1.0 \text{ mA})$	t_d	—	35	ns
Rise Time		t_r	—	35	
Storage Time	$(V_{CC} = -3.0 \text{ Vdc}, I_C = -10 \text{ mA}, I_{B1} = I_{B2} = -1.0 \text{ mA})$	t_s	—	225	ns
Fall Time		t_f	—	75	

3. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

Rating and Characteristic Curves (MMBT3906)



* Total shunt capacitance of test jig and connectors

**Figure 1. Delay and Rise Time
Equivalent Test Circuit**

**Figure 2. Storage and Fall Time
Equivalent Test Circuit**

TYPICAL TRANSIENT CHARACTERISTICS

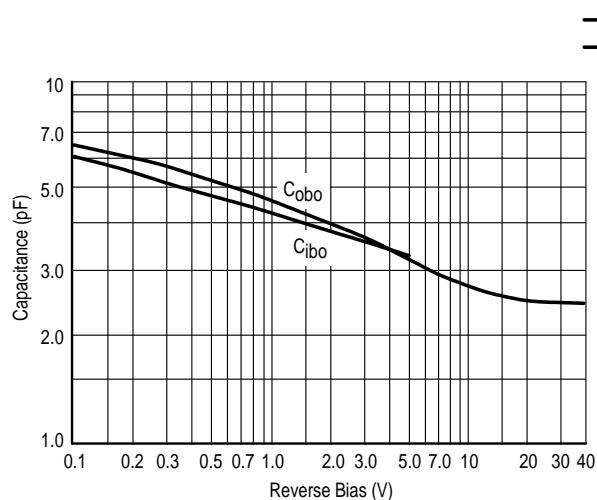


Figure 3. Capacitance

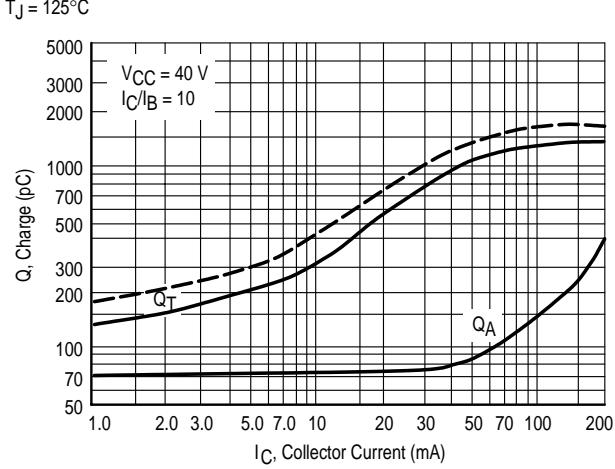


Figure 4. Charge Data

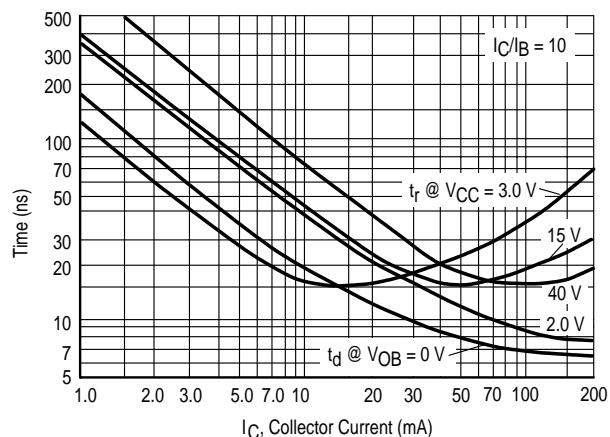


Figure 5. Turn-On Time

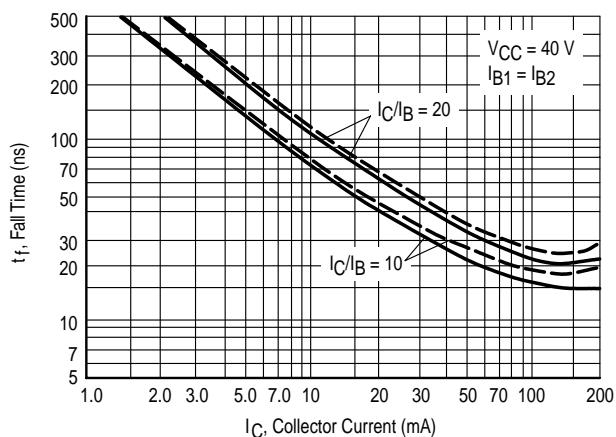


Figure 6. Fall Time

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Rating and Characteristic Curves (MMBT3906)

TYPICAL AUDIO SMALL-SIGNAL CHARACTERISTICS

NOISE FIGURE VARIATIONS

($V_{CE} = -5.0$ Vdc, $T_A = 25^\circ\text{C}$, Bandwidth = 1.0 Hz)

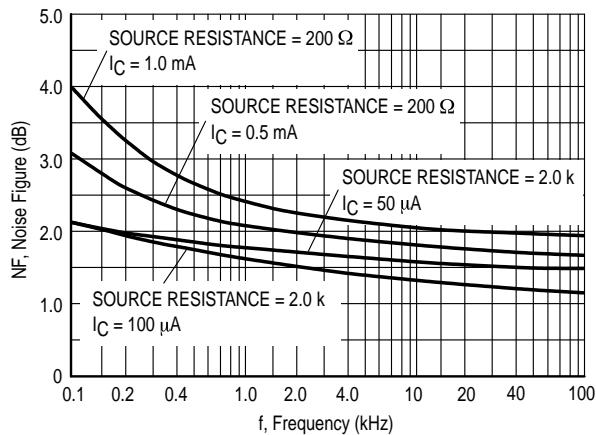


Figure 7.

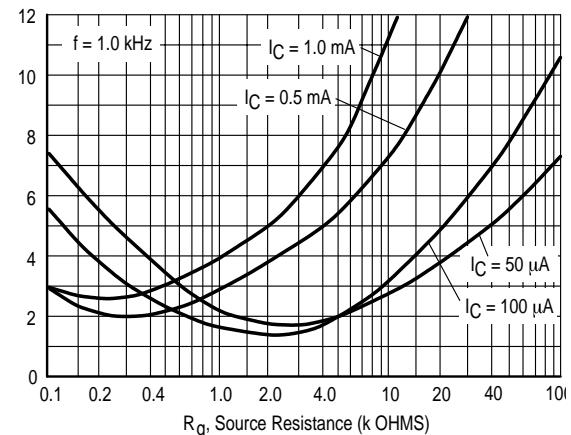


Figure 8.

h PARAMETERS

($V_{CE} = -10$ Vdc, $f = 1.0$ kHz, $T_A = 25^\circ\text{C}$)

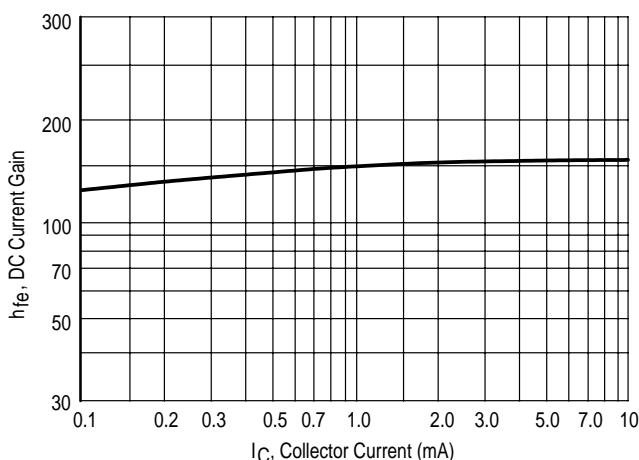


Figure 9. Current Gain

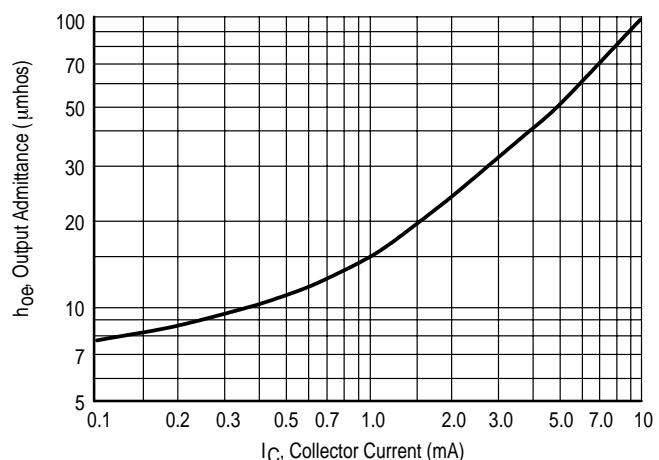


Figure 10. Output Admittance

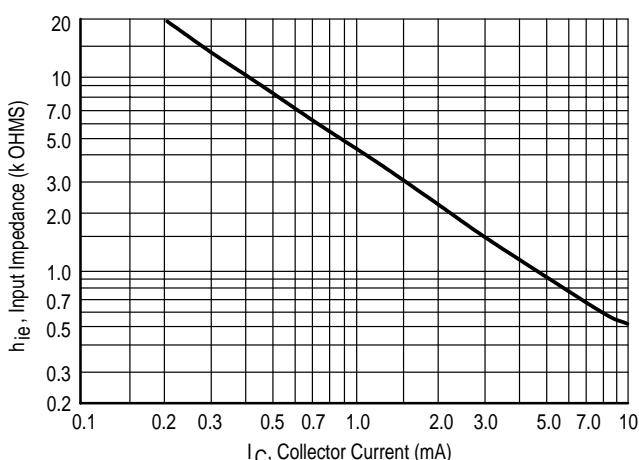


Figure 11. Input Impedance

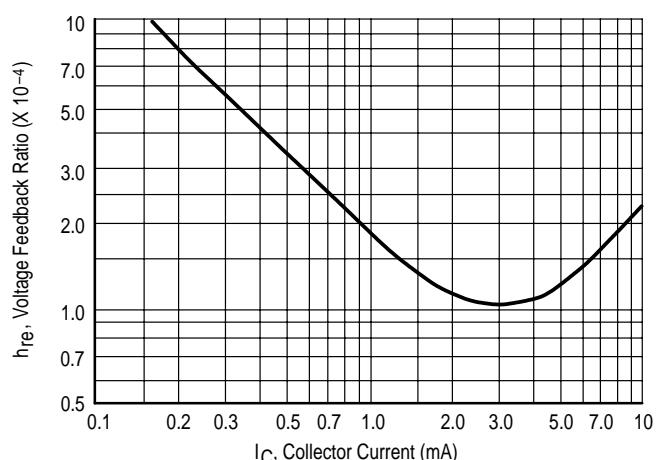


Figure 12. Voltage Feedback Ratio

Rating and Characteristic Curves (MMBT3906)

TYPICAL STATIC CHARACTERISTICS

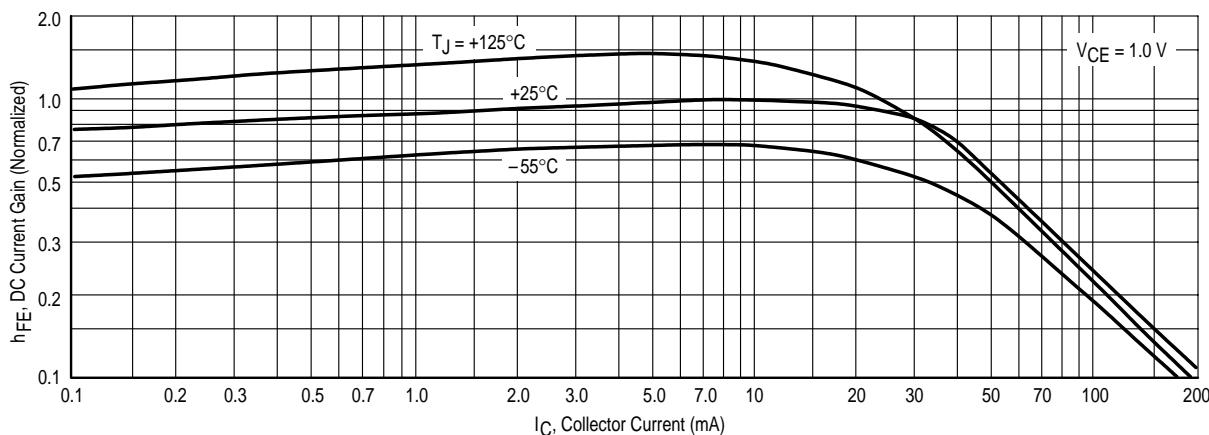


Figure 13. DC Current Gain

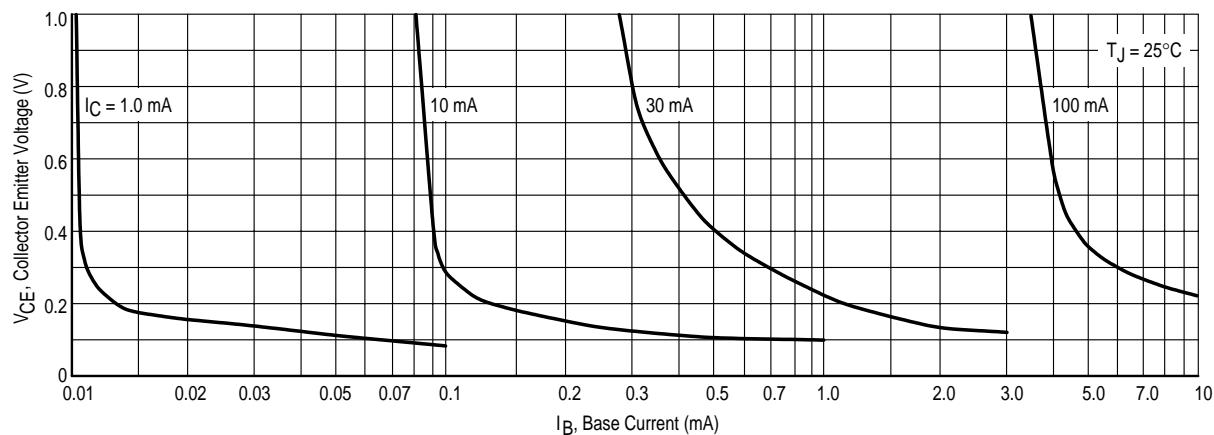


Figure 14. Collector Saturation Region

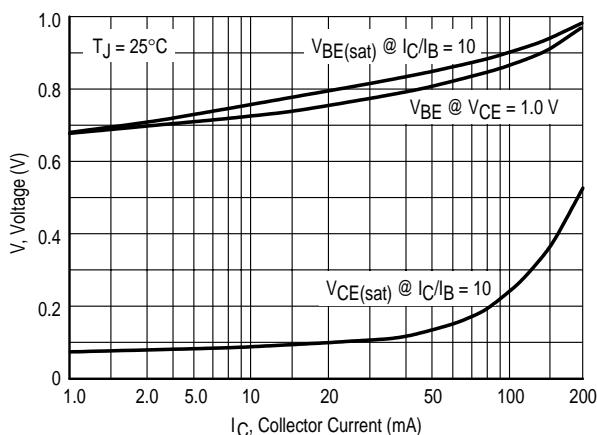


Figure 15. "ON" Voltages

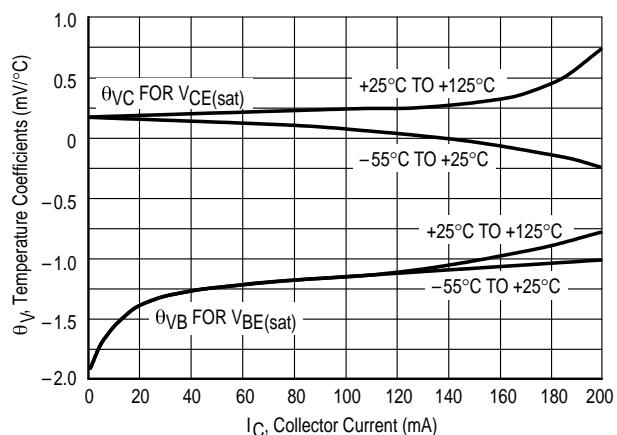


Figure 16. Temperature Coefficients